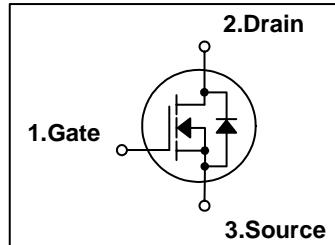


N-Channel MOSFET

Features

- $R_{DS(on)}$ (Max 1 Ω) @ $V_{GS} = 10V$
- Gate Charge (Typical 32nC)
- Improved dv/dt Capability
- High ruggedness
- 100% Avalanche Tested

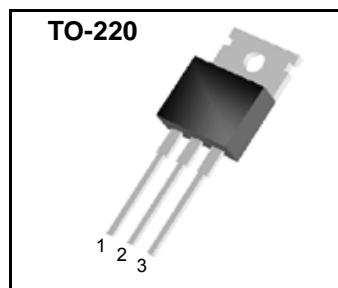


$BV_{DSS} = 400V$
 $R_{DS(ON)} = 1 \text{ ohm}$
 $I_D = 6.5A$

General Description

This N-channel enhancement mode field-effect power transistor using DI semiconductor's advanced planar stripe, DMOS technology intended for off-line switch mode power supply.

Also, especially designed to minimize $r_{ds(on)}$ and high rugged avalanche characteristics. The TO-220 pkg is well suited for half bridge and full bridge resonant topology like a electronic ballast .



Absolute Maximum Ratings

Symbol	Parameter	Value	Units
V_{DSS}	Drain to Source Voltage	400	V
I_D	Continuous Drain Current(@ $T_C = 25^\circ\text{C}$)	6.5	A
	Continuous Drain Current(@ $T_C = 100^\circ\text{C}$)	2.9	A
I_{DM}	Drain Current Pulsed (Note 1)	26	A
V_{GS}	Gate to Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	470	mJ
E_{AR}	Repetitive Avalanche Energy (Note 1)	9.8	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	5.3	V/ns
P_D	Total Power Dissipation(@ $T_C = 25^\circ\text{C}$)	98	W
	Derating Factor above 25°C	0.78	W/ $^\circ\text{C}$
T_{STG}, T_J	Operating Junction Temperature & Storage Temperature	- 55 ~ 150	$^\circ\text{C}$
T_L	Maximum Lead Temperature for soldering purpose, 1/8 from Case for 5 seconds.	300	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Value			Units
		Min.	Typ.	Max.	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	-	1.28	$^\circ\text{C/W}$
$R_{\theta CS}$	Thermal Resistance, Case to Sink	-	0.5	-	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	-	-	62.5	$^\circ\text{C/W}$

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Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

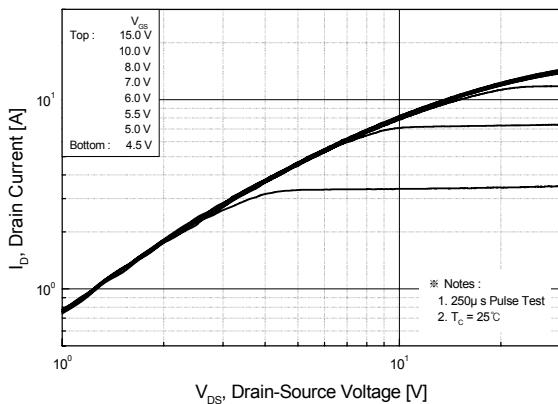
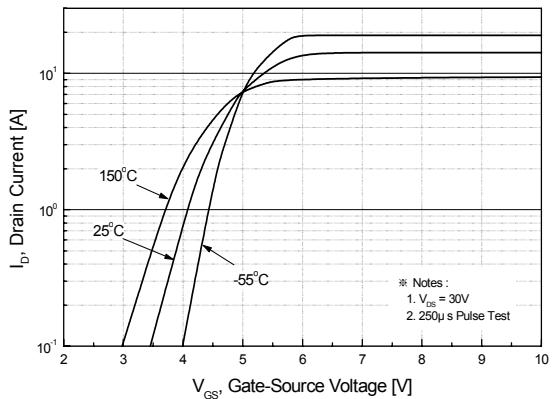
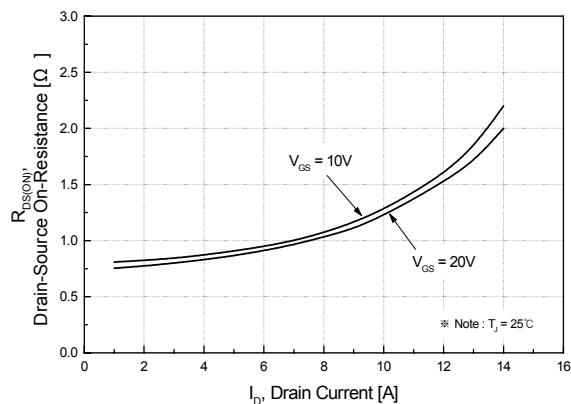
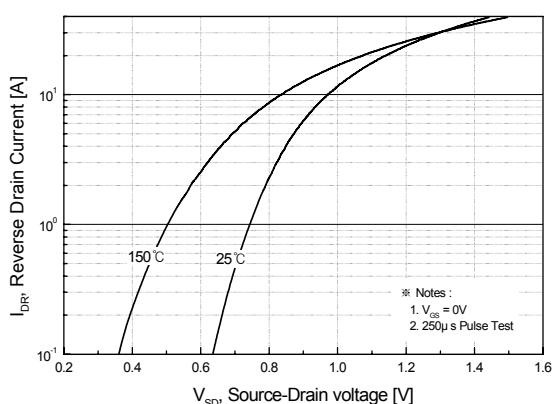
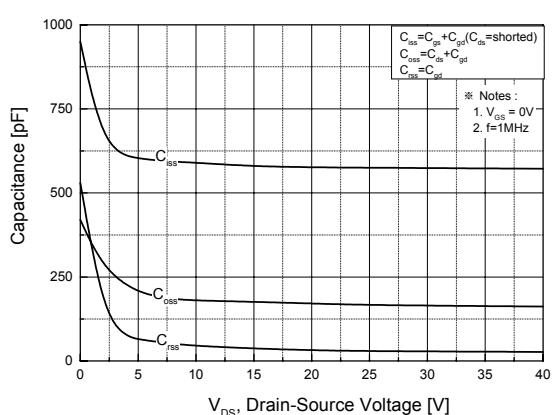
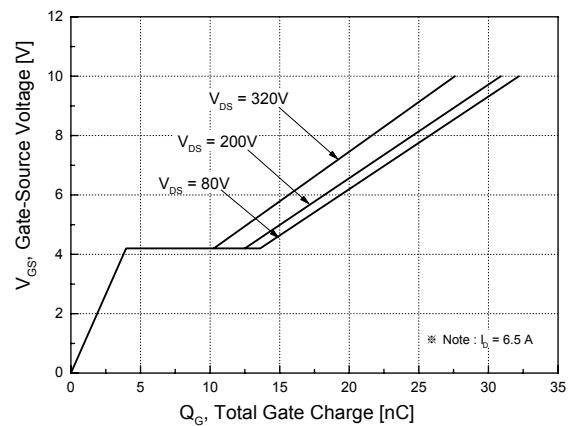
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$	400	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temperature coefficient	$I_D = 250\mu\text{A}$, referenced to 25°C	-	0.544	-	$\text{V}/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}} = 400\text{V}$, $V_{\text{GS}} = 0\text{V}$	-	-	1	μA
		$V_{\text{DS}} = 320\text{V}$, $T_C = 125^\circ\text{C}$	-	-	10	μA
I_{GSS}	Gate-Source Leakage, Forward	$V_{\text{GS}} = 30\text{V}$, $V_{\text{DS}} = 0\text{V}$	-	-	100	nA
	Gate-source Leakage, Reverse	$V_{\text{GS}} = -30\text{V}$, $V_{\text{DS}} = 0\text{V}$	-	-	-100	nA
On Characteristics						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 250\mu\text{A}$	2.0	-	4.0	V
$R_{\text{DS(ON)}}$	Static Drain-Source On-state Resistance	$V_{\text{GS}} = 10\text{V}$, $I_D = 3.25\text{A}$	-	0.71	1	Ω
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 25\text{V}$, $f = 1\text{MHz}$	-	575	750	pF
C_{oss}	Output Capacitance		-	165	215	
C_{rss}	Reverse Transfer Capacitance		-	30	40	
Dynamic Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}} = 200\text{V}$, $I_D = 6.5\text{A}$, $R_G = 25\Omega$ ※ see fig. 13. (Note 4, 5)	-	28	36	ns
t_r	Rise Time		-	74	96	
$t_{\text{d(off)}}$	Turn-off Delay Time		-	128	166	
t_f	Fall Time		-	38	50	
Q_g	Total Gate Charge	$V_{\text{DS}} = 320\text{V}$, $V_{\text{GS}} = 10\text{V}$, $I_D = 6.5\text{A}$	-	32	42	nC
Q_{gs}	Gate-Source Charge		-	13	-	
Q_{gd}	Gate-Drain Charge(Miller Charge)		-	4	-	

Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit.
I_S	Continuous Source Current	Integral Reverse p-n Junction Diode in the MOSFET	-	-	6.5	A
	Pulsed Source Current		-	-	26	
V_{SD}	Diode Forward Voltage	$I_S = 6.5\text{A}$, $V_{\text{GS}} = 0\text{V}$	-	-	1.5	V
t_{rr}	Reverse Recovery Time	$I_S = 6.5\text{A}$, $V_{\text{GS}} = 0\text{V}$, $dI_F/dt = 100\text{A/us}$	-	320	-	ns
	Reverse Recovery Charge		-	1.46	-	uC

※ NOTES

1. Repeatability rating : pulse width limited by junction temperature
2. $L = 19.4\text{mH}$, $I_{AS} = 6.5\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 50\Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 6.5\text{A}$, $dI/dt \leq 300\text{A/us}$, $V_{DD} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse Width $\leq 300\text{us}$, Duty Cycle $\leq 2\%$
5. Essentially independent of operating temperature.

DFP730**Fig 1. On-State Characteristics****Fig 2. Transfer Characteristics****Fig 3. On Resistance Variation vs. Drain Current and Gate Voltage****Fig 4. On State Current vs. Allowable Case Temperature****Fig 5. Capacitance Characteristics****Fig 6. Gate Charge Characteristics**

DFP730

Fig 7. Breakdown Voltage Variation vs. Junction Temperature

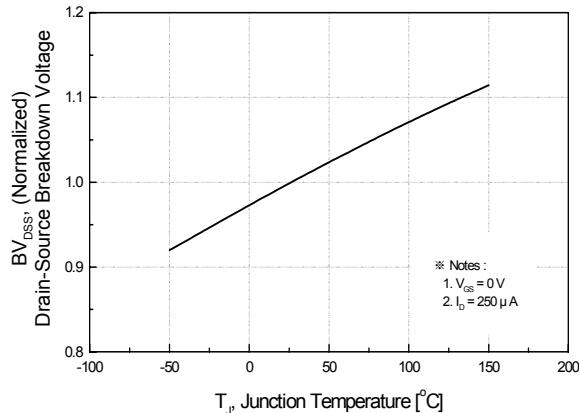


Fig 8. On-Resistance Variation vs. Junction Temperature

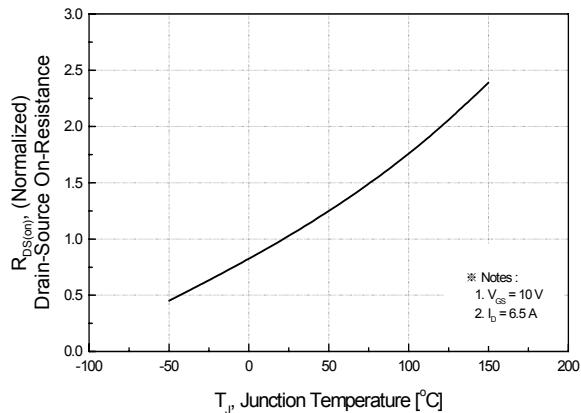


Fig 9. Maximum Safe Operating Area

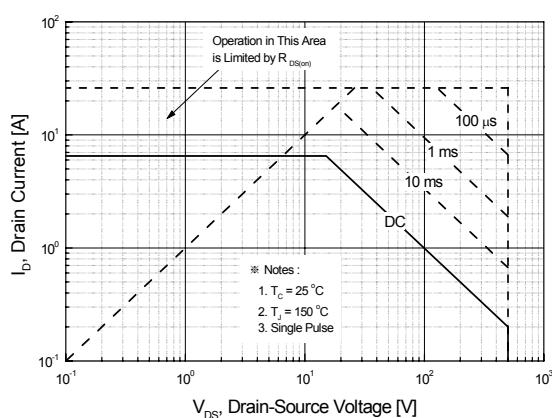


Fig 10. Maximum Drain Current vs. Case Temperature

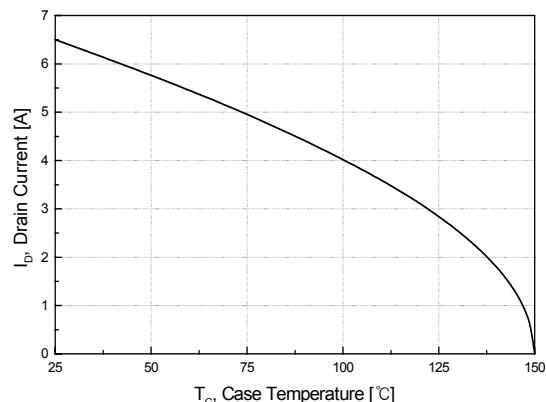
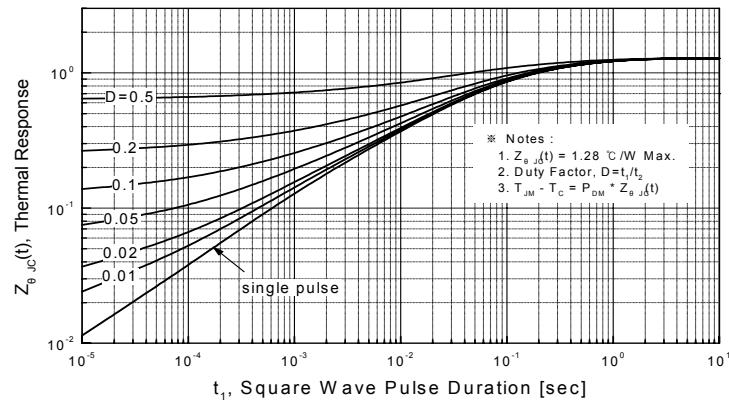
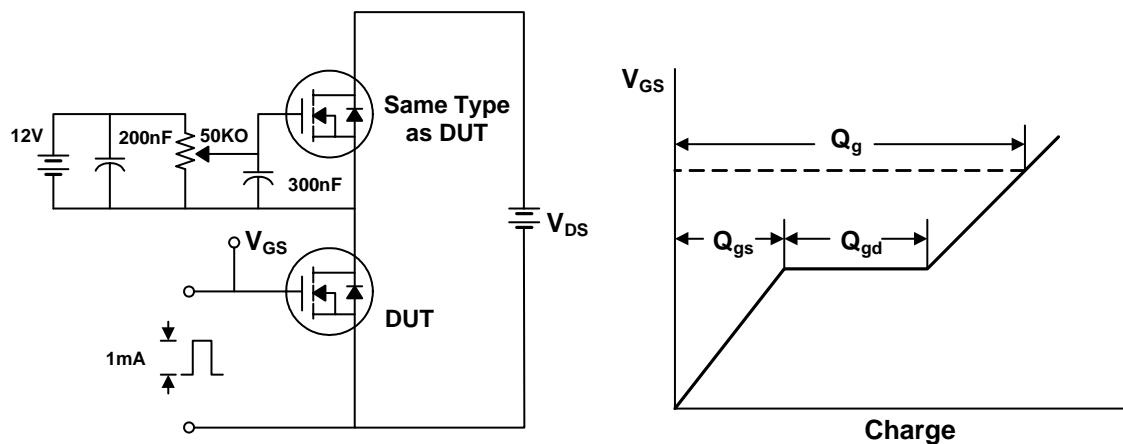
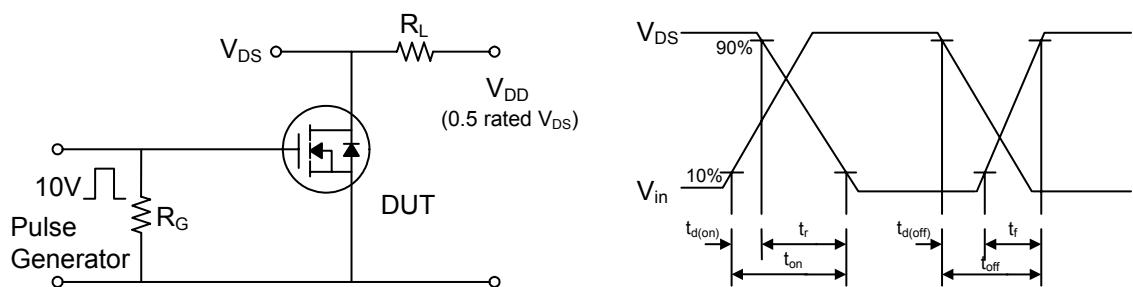
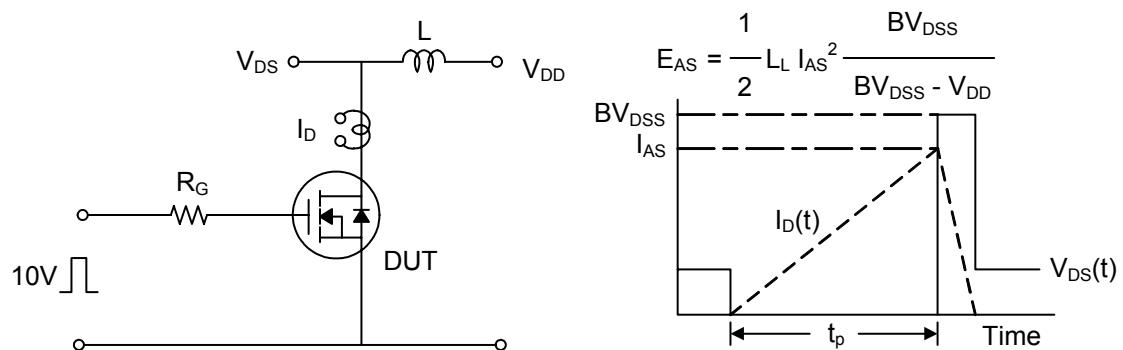


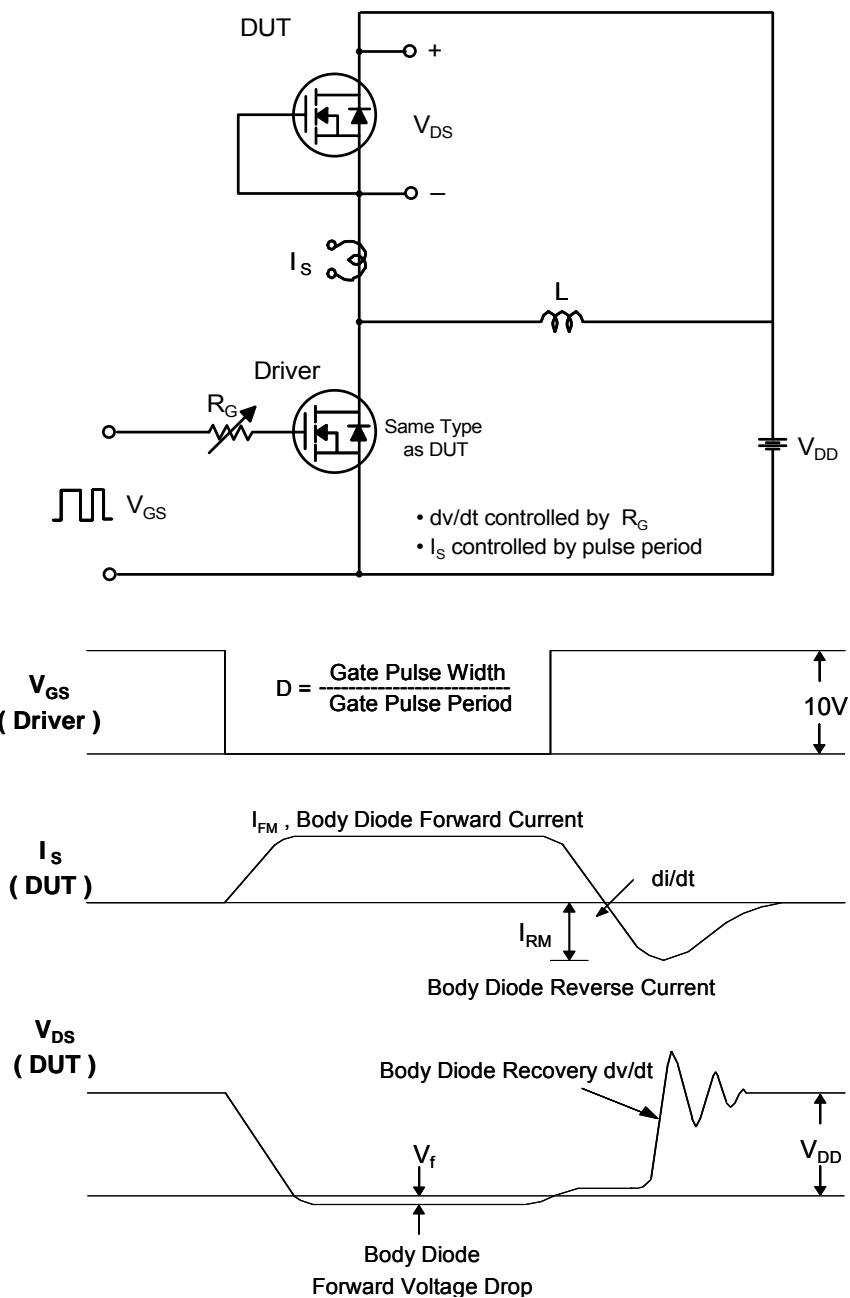
Fig 11. Transient Thermal Response Curve

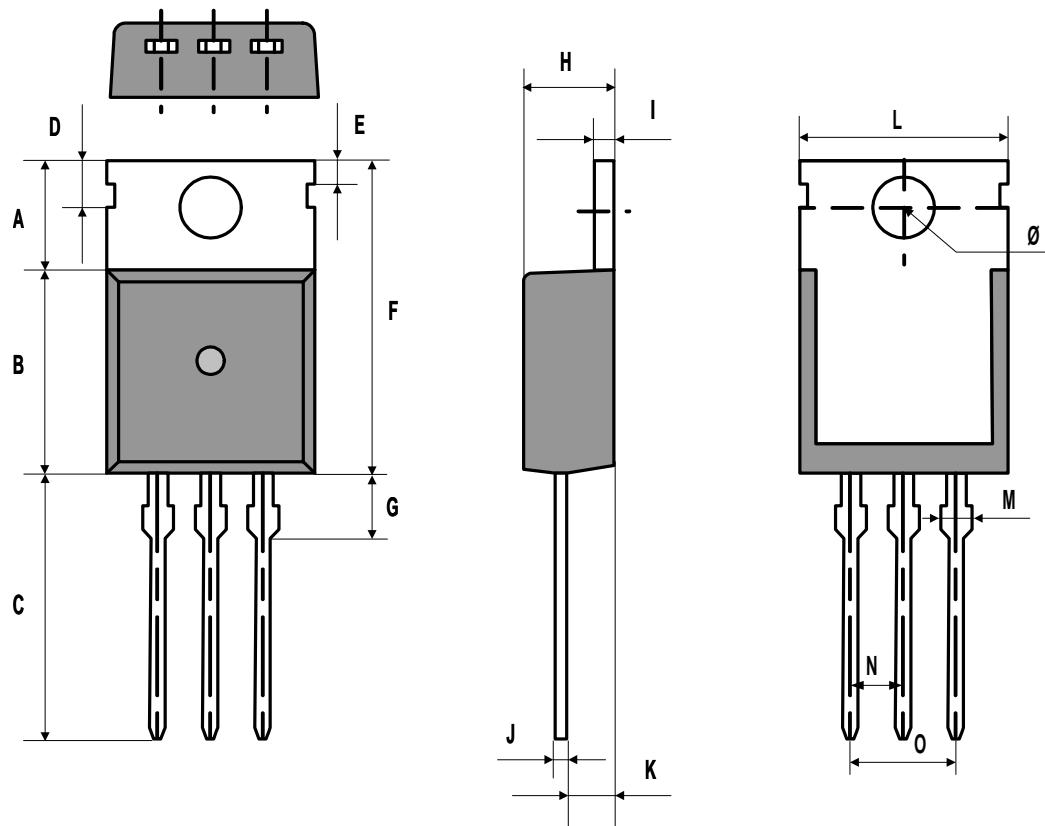


DFP730**Fig. 12. Gate Charge Test Circuit & Waveforms****Fig 13. Switching Time Test Circuit & Waveforms****Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

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Fig. 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



DFP730**TO-220 Package Dimension**

DIMENSION	A	B	C	D	E	F	G	H
mm	Min	6.12	9.00	12.88	2.70	1.20	15.12	2.70
	Typ.	6.32	9.20	13.08	2.80	1.30	15.52	3.00
	Max	6.52	9.40	13.28	2.90	1.40	15.92	4.70

DIMENSION	I	J	K	L	M	N	O	Ø
mm	Min	1.25	0.45	2.30		1.42	2.44	4.88
	Typ.	1.30	0.50	2.40	9.90	1.52	2.54	5.08
	Max	1.40	0.60	2.50		1.62	2.64	5.28